

250kSPS 16-BIT Differential ADC in µS0

Preliminary Technical Data

AD7687*

FEATURES

16 Bits Resolution with No Missing 16-Bit Codes

Throughput: 250 kSPS

INL: \pm 1.5LSB Max (\pm 0.0023 % of Full-Scale)

S/(N+D): 93 dB Typ @ 10 kHz THD: -100 dB Typ @ 10 kHz

True Differential Analog input range: $\pm V_{REF}$ 0V to V_{REF} with V_{REF} up to VDD on both Inputs

No Pipeline Delay

Single Supply Operation 5V and 2.7V with 2.5V/3V/5V logic interface

Multiple ADCs Daisy Chain and Busy Indicator Serial Interface SPI/QSPI/μWire/DSP compatible 20 mW @ 5V/250ksps, TBD @ 3V Typical Power

Dissipation, 80 μW @ 1 kSPS

Stand-by current (acquisition phase): 1 μA Max

 μ -SOIC Package (μ -SO8 size)

Pin-to-Pin Compatible with the AD7685, AD7686, AD7688

Battery Powered Equipment
Data Acquisition
Instrumentation
Medical Instruments
Process Control

GENERAL DESCRIPTION

The AD7687 is a 16-bit, 250 kSPS, charge redistribution successive-approximation, truly differential Analog-to-Digital Converter which operates from a single power supply. It contains a high-speed 16-Bit sampling ADC with no missing codes, an internal conversion clock, error correction circuits and a flexible serial interface port. The part also contain a low noise, wide bandwidth, very short aperture delay track/hold circuit which can sample a $\pm V_{\rm REF}$ analog input range. The reference voltage REF is applied externally and can be set up to the supply voltage.

The serial interface features the capability to "Daisy chain" several ADCs on a single 3 wire bus and provides an optional Busy indicator.

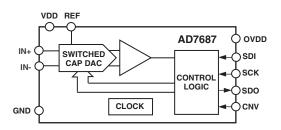
The AD7687 is hardware factory calibrated. It is fabricated using CMOS process and is housed in 10-lead μ SOIC package with operation specified from -40°C to +85°C.

*Patent pending.

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FUNCTIONAL BLOCK DIAGRAM



µSO/SOT23 16 Bit ADC

Type / kSPS	100 kSPS	250 kSPS	380 - 550 kSPS
True	AD7684	<u>AD7687</u>	<u>AD7688</u>
Differential			
Pseudo	AD7683	<u>AD7685</u>	<u>AD7686</u>
Differential			
Unipolar	<u>AD7680</u>		

PRODUCT HIGHLIGHTS

1. Superior INL

The AD7687 has a maximum integral non linearity of 1.5 LSB with no missing 16-bit code.

2. 2.7V or 5V Single Supply Operation

The AD7687 operates from a single supply, dissipates only TBD mW typical, and even lower when a reduced throughput is used. It consumes 1 μ A maximum during the acquisition phase.

3. Fast Throughput.

The AD7687 is a high speed 250 kSPS, charge redistribution, 16-Bit SAR ADC with no pipeline delay.

4. Serial Interface with OVDD, Daisy Chain and Busy 2.5V, 3 V or 5 V logic 3-wire serial interface arrangement compatible with SPI and DSP host.

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AD7687—SPECIFICATIONS $(T_A = -40$ °C to +85°C, $V_{REF} = 5V$, VDD = 5 V, OVDD = 2.3V to 5.25V, unless otherwise noted.)

Parameter	Conditions	Min	Typ	Max	Unit
RESOLUTION		16			Bits
ANALOG INPUT Voltage Range Absolute Input Voltage Analog Input CMRR Leakage Current at 25 °C Input Impedance	IN+ - IN- IN+ IN- f _{IN} = TBD kHz 250kSPS Throughput	-V _{REF} -0.1 -0.1	TBD TBD See Analog Input Se	+V _{REF} VDD+0.3 VDD+0.3	V V V d B n A
THROUGHPUT SPEED Complete Cycle Throughput Rate		0		4 250	μs kSPS
DC ACCURACY No Missing Codes Integral Linearity Error Transition Noise Gain Error ² , T _{MIN} to T _{MAX} Gain Error Temperature Drift Offset Error ² , T _{MIN} to T _{MAX} Offset Temperature Drift Power Supply Sensitivity	REF = 5 V VDD = 5 V ± 5%	16 -1.5	0.4 ±TBD ±TBD ±TBD ±TBD	+1.5 ±TBD ±TBD	Bits LSB ¹ LSB % of FSR ppm/°C LSB ppm/°C LSB
AC ACCURACY Signal-to-Noise Spurious Free Dynamic Range Total Harmonic Distortion Signal-to-(Noise+Distortion)	$\begin{array}{l} f_{\mathrm{IN}} = \mathrm{TBD} \ \mathrm{kHz} \\ f_{\mathrm{IN}} = \mathrm{TBD} \ \mathrm{kHz} , \\ -60 \ \mathrm{dB} \ \mathrm{Input} \end{array}$	92	93 100 -100 93	TBD	dB ³ dB dB dB
Intermodulation Distortion Second Order Terms Third Order Terms -3 dB Input Bandwidth	oo ub input		TBD TBD 2		dB dB dHz
SAMPLING DYNAMICS Aperture Delay Aperture Jitter Transient Response	Full-Scale Step		TBD TBD	1.5	ns ps rms μs
REFERENCE External Reference Voltage External Reference Current Drain	250kSPS Throughput	0.5	ТВД	VDD+0.3	V μ Α
	OVDD = 2.7V to 5.25V OVDD = 2.3V to 5.25V	-0.3 +2.0 +1.7 -1		+0.8 OVDD + 0.3 OVDD + 0.3 +1 +1	V V V μ A μ A
DIGITAL OUTPUTS Data Format Pipeline Delay V _{OL} V _{OH}	I _{SINK} = 500 μA I _{SOURCE} = -500 μA	Co OVDD	Serial 16-Bits Two nversion Results Availa After Completed Co	able Immediately	V V

Specifications subject to change without notice.

 $^{^1}LSB$ means Least Significant Bit. With the 5 V input range, one LSB is 152.6 $\mu V.$

²See Definition of Specifications section. These specifications do include full temperature range variation but do not include the error contribution from the external reference.

³All specifications in dB are referred to a full-scale input FS. Tested with an input signal at 0.5 dB below full-scale unless otherwise specified.

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Parameter	Conditions	Min	Typ	Max	Unit	
POWER SUPPLIES						
VDD	Specified Performance	4.75	5	5.25	V	
VDD Range	-	2.7		5.25	V	
OVDD		2.7		5.25	V	
Operating Current	250 kSPS Throughput					
VDD	VDD = 5V		TBD		m A	
OVDD			TBD		μΑ	
Power Dissipation (VDD = 5V)	250 kSPS Throughput4		20	TBD	m W	
	1 kSPS Throughput ⁴		80		μW	
	During acquisition phase ⁴			TBD	μW	
TEMPERATURE RANGE ⁵						
Specified Performance	T_{MIN} to T_{MAX}	-40		+85	°C	

NOTES

	Symbol	Min	Typ	Max	Unit
Conversion Time: CNV Rising Edge to Data available	t _{CONV}	1.1		2.5	μs
Acquisition Time	t _{ACQ}	1.5			μs
Time Between Conversions	t _{CYC}	4			μs
CNV Pulse width ($\overline{\text{CS}}$ mode)	t _{CNVH}	5			ns
SCK Period	t _{SCK}	15			ns
SCK Low Time	t _{SCKH}	7			ns
SCK High Time	t _{SCKL}	7			ns
SCK Falling Edge to Data remains Valid	t _{HSDO}	5			ns
SCK Falling Edge to Data Valid delay	t _{DSDO}				
OVDD above 4.75V				13	ns
OVDD above 3V				20	ns
OVDD above 2.7V				27	ns
CNV or SDI Low to SDO D15 MSB Valid (CS mode)	t _{EN}				
OVDD above 4.75V				15	ns
OVDD above 2.7V				30	ns
CNV or SDI High or last SCK Falling Edge					
to SDO High Impedance (CS mode)	t _{DIS}			30	ns
SDI valid Setup Time from CNV rising edge (CS mode)	t _{SSDICNV}	8			ns
SDI valid Hold Time from CNV rising edge ($\overline{\text{CS}}$ mode)	t _{HSDICNV}	0			ns
SCK valid Setup Time from CNV rising edge (Chain mode)	t _{SSCKCNV}	8			ns
SCK valid Hold Time from CNV rising edge (Chain mode)	t _{HSCKCNV}	5			ns
SDI valid Setup Time from SCK falling edge (Chain mode)	t _{SSDISCK}	8			ns
SDI valid Hold Time from SCK falling edge (Chain mode)	t _{HSDISCK}	0			ns
SDI High to SDO High (Chain mode with Busy indicator)	t _{DSDOSDI}				
OVDD above 4.75V				15	ns
OVDD above 2.7V				30	ns

⁴With all digital inputs forced to OVDD or GND respectively.

⁵Contact factory for extended temperature range.

Specifications subject to change without notice.

AD7687—SPECIFICATIONS

ABSOLUTE MAXIMUM RATINGS¹

ABSOLUTE MERMINEM MATTINGS
Analog Inputs
$IN+^2$, $IN-^2$, REF,GND -0.3 V to VDD + 0.3 V
Supply Voltages
VDD, OVDD to GND0.3 V to 7 V
VDD to OVDD±7 V
Digital Inputs to GND0.3 V to OVDD + 0.3 V
Digital Outputs to GND0.3 V to OVDD + 0.3 V

Internal Power Dissipation ³	. 325 mW
Junction Temperature	150°C
Storage Temperature Range65°C	to +150°C
Lead Temperature Range	
(Soldering 10 sec)	300°C

NOTES

¹Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option	Brand
AD7687BRM AD7687BRMRL7 EVAL-AD7687CB ¹ EVAL-CONTROL BRD2 ² EVAL-CONTROL BRD3 ²	-40°C to +85°C -40°C to +85°C	μSOIC-10 μSOIC-10 Evaluation Board Controller Board Controller Board	RM-10 RM-10 (reel)	C03 C03

NOTES

¹This board can be used as a standalone evaluation board or in conjunction with the EVAL-CONTROL BRDx for evaluation/demonstration purposes.

²These boards allow a PC to control and communicate with all Analog Devices evaluation boards ending in the CB designators.

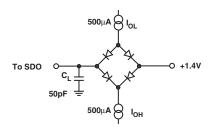


Figure 1. Load Circuit for Digital Interface Timing.

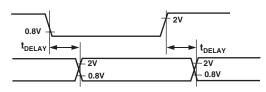
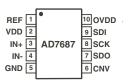


Figure 2. Voltage Reference Levels for Timing.

AD7687 PIN CONFIGURATION



CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD7687 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



²See Analog Input section.

³Specification is for device in free air: μ SOIC-10: $\theta_{JA} = 200^{\circ}$ C/W.

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PIN FUNCTION DESCRIPTIONS

Pin #	Mnemonic		Function
1	REF	ΑI	Reference Input Voltage. The REF range is from TBD to VDD. It is referred to the GND ground. This pin should be decoupled closely to the pin with a TBD μFcapacitor.
2	VDD	P	Input Power Supply.
3	I N +	ΑI	Differential Positive Analog Input.
4	IN-	ΑI	Differential Positive Analog Input.
5	GND	P	Power Supply Ground.
6	CNV	DI	Convert Input. This input has multiple functions. On its leading edge, it initiates the conversions, it selects the interface mode of the part, Chain or \overline{CS} mode, and in chain mode, it enables the busy indicator feature if SCK is high. In \overline{CS} mode, it can enable the serial output signal when low. In Chain mode, the data should be read when CNV is high.
7	SDO	DO	Serial Data Output. The conversion result or the programming configuration word are ouput on this pin. It is synchronized to SCK.
8	SCK	DΙ	Serial Data Clock Input.
9	SDI	DΙ	Serial Data Input. This input provides multiple features. It selects the interface mode of the ADC as follows: The Chain mode is selected if SDI is low during the CNV rising edge. In this Chain mode, SDI could be used as a data input to daisy chain the conversion results from two or more ADCs onto a single SDO line. The digital data level on SDI is output on SDO with a delay of 16 SCK cycles.
10	OVDD	P	The \overline{CS} mode is selected if SDI is high during the CNV rising edge. In this \overline{CS} mode, either SDI or CNV can enable the serial output signals when low and if SDI or CNV is low when the conversion is complete, the busy indicator feature is enabled. Input/Output Interface Digital Power. Nominally at the same supply than the host interface (2.5V, 3V or 5V).

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NOTES

AI = Analog Input DI = Digital Input DO = Digital Output

P = Power

AD7687

DEFINITION OF SPECIFICATIONS

INTEGRAL NONLINEARITY ERROR (INL)

Linearity error refers to the deviation of each individual code from a line drawn from "negative full scale" through "positive full scale". The point used as "negative full scale" occurs 1/2 LSB before the first code transition. "Positive full scale" is defined as a level 1 1/2 LSB beyond the last code transition. The deviation is measured from the middle of each code to the true straight line.

DIFFERENTIAL NONLINEARITY ERROR (DNL)

In an ideal ADC, code transitions are 1 LSB apart. Differential nonlinearity is the maximum deviation from this ideal value. It is often specified in terms of resolution for which no missing codes are guaranteed.

GAIN ERROR

The last transition (from 111...10 to 111...11) should occur for an analog voltage 1 1/2 LSB below the nominal full scale (4.999886 V for the 0 V to 5 V range). The gain error is the deviation of the actual level of the last transition from the ideal level after the offset has been adjusted out.

OFFSET ERROR

The first transition should occur at a level 1/2 LSB above analog ground (38.1 μV for the 0 V to 5 V range). The offset error is the deviation of the actual transition from that point.

SPURIOUS FREE DYNAMIC RANGE (SFDR)

The difference, in decibels (dB), between the rms amplitude of the input signal and the peak spurious signal.

EFFECTIVE NUMBER OF BITS (ENOB)

ENOB is a measurement of the resolution with a sine wave input. It is related to S/(N+D) by the following formula:

ENOB =
$$(S/[N+D]_{dB} - 1.76)/6.02)$$

and is expressed in bits.

TOTAL HARMONIC DISTORTION (THD)

THD is the ratio of the rms sum of the first five harmonic components to the rms value of a full-scale input signal and is expressed in decibels.

SIGNAL-TO-NOISE RATIO (SNR)

SNR is the ratio of the rms value of the actual input signal to the rms sum of all other spectral components below the Nyquist frequency, excluding harmonics and dc. The value for SNR is expressed in decibels.

SIGNAL TO (NOISE + DISTORTION) RATIO (S/[N+D])

S/(N+D) is the ratio of the rms value of the actual input signal to the rms sum of all other spectral components below the Nyquist frequency, including harmonics but excluding dc. The value for S/(N+D) is expressed in decibels.

APERTURE DELAY

Aperture delay is a measure of the acquisition performance and is measured from the rising edge of the CNV input to when the input signal is held for a conversion.

TRANSIENT RESPONSE

The time required for the AD7687 to achieve its rated accuracy after a full-scale step function is applied to its input.

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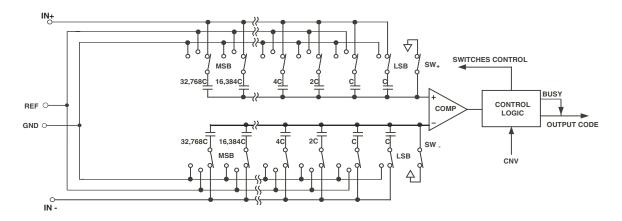


Figure 3. ADC Simplified Schematic

CIRCUIT INFORMATION

The AD7687 is a fast, low-power, single-supply, precise 16-bit analog-to-digital converter (ADC). The AD7687 is capable of converting 250,000 samples per second (250 kSPS) and allow power saving between conversions. When operating at 1kSPS, for example, it consumes typically 48 μ W with a 3V supply, ideal for battery-powered applications.

The AD7687 provides the user with an on-chip track/hold, successive approximation ADC that does not exhibit any pipeline or latency, making it ideal for multiple multiplexed channel applications.

The AD7687 can be operated from a single 2.7 V to 5.5V supply and be interfaced to either 5 V or 3.3 V or 2.5 V digital logic. It is housed in a 10-lead μ SO package that combines space savings and allows flexible configurations. The AD7687 is pin-to-pin-compatible with the AD7685, the AD7686 and the AD7688.

The CNV rising edge is used as a sampling edge. It puts the track and hold in hold position and initiates the conversion process. Because the AD7687 has an on board conversion clock, the serial clock SCK is not required for the conversion process. When the conversion is complete and whatever the CNV state is, the part returns automatically in a power-down mode with the track and hold in track position.

CONVERTER OPERATION

The AD7687 is a successive approximation analog-to-digital converter based on a charge redistribution DAC. Figure 3 shows the simplified schematic of the ADC. The capacitive DAC consists of two identical arrays of 16 binary weighted capacitors which are connected to the two comparator inputs.

During the acquisition phase, terminals of the array tied to the comparator's input are connected to GND via SW₊ and SW₋. All independent switches are connected to the analog inputs. Thus, the capacitor arrays are used as sampling capacitors and acquire the analog signal on IN+ and IN- inputs. When the acquisition phase is complete and the CNV input goes high, a conversion phase is initiated.

When the conversion phase begins, SW₊ and SW₋ are opened first. The two capacitor arrays are then disconnected from the inputs and connected to the GND input. Therefore, the differential voltage between the inputs IN+ and IN- captured at the end of the acquisition phase is applied to the comparator inputs, causing the comparator to become unbalanced. By switching each element of the capacitor array between GND or REF, the comparator input varies by binary weighted voltage steps (V_{REF}/2, V_{REF}/4...V_{REF}/65536). The control logic toggles these switches, starting with the MSB first, in order to bring the comparator back into a balanced condition. After the completion of this process, the control logic generates the ADC output code and a BUSY signal indicator.

Transfer Functions

The ideal transfer characteristic for the AD7687 is shown in Figure 4 and Table I.

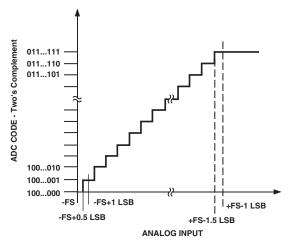


Figure 4. ADC Ideal Transfer Function

AD7687

Table I. Output Codes and Ideal Input Voltages

Description	Analog Input V _{REF} = 5V	Digital Output Code Hexa
FSR -1 LSB Midscale + 1 LSB Midscale Midscale - 1 LSB -FSR + 1 LSB -FSR	4.999847 V 152.6μV 0 V -152.6μV -4.999847V -5 V	7FFF ¹ 0001 0000 FFFF 8001 8000 ²

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NOTES $^{1}\text{This}$ is also the code for overrange analog input (V $_{IN+}$ – V_{IN-} above

 V_{REF} – $V_{GND}).$ $<math display="inline">^2This$ is also the code for underrange analog input (V $_{IN+}$ – V_{IN-} below $V_{GND}\,-\,\,V_{REF}$).

DIGITAL INTERFACE

Though the AD7687 has a reduced number of pins, it offers flexibility in its serial interface modes:

The AD7687, used in " $\overline{\text{CS}}$ mode", is compatible to SPI, QSPI digital hosts and DSPs (e.g.:Blackfin ADSP-BF53x or ADSP-219x). This interface can use either 3 or 4 wires. Three wires interface using CNV, SCK and SDO signals, minimizes wiring connections useful, for instance, in isolated applications. Four wires interface using SDI, CNV, SCK and SDO signals allows CNV, used to initiate the conversions, to be independent of the reading timing (SDI). That is useful in, low jitter sampling or simultaneous sampling applications.

The AD7687, used in "Chain mode", provides a "daisy chain" feature using the SDI input for cascading multiple ADCs on a single data line.

The mode in which the part operates depends on the SDI level when the CNV rising edge occurs. The \overline{CS} mode is selected if SDI is high and the chain mode is selected if SDI is low. The SDI hold time is such that when SDI and CNV are connected together, the chain mode is always selected.

The AD7687 also offers the possibility, as an option and with both modes, to force a start bit in front of the 16 data bits. This start bit can be used as a busy signal indicator to interrupt the digital host and trigger the data reading.

The busy indicator is output or not depending on the mode as follows:

In \overline{CS} mode, the busy indicator occurs if CNV or SDI is low when the ADC conversion ends.

In Chain mode, the busy indicator will be outputed if SCK is high during the CNV rising edge.

CS MODE 3 wires without Busy indicator

This mode is usually used when a single AD7687 is connected to an SPI compatible digital host. The connection diagram is shown in figure 5 and the corresponding timing is given in figure 6.

With SDI tied to OVDD, a rising edge on CNV initiates a conversion, selects the \overline{CS} mode and forces SDO in high impedance. Once a conversion is initiated, it will be processed until completion whatever the state of CNV is. For instance, it could be useful to bring CNV low to select other SPI devices such as analog multiplexers but CNV must be returned high before the minimum conversion time and held high until the maximum conversion time to avoid the generation of the busy signal indicator. When the conversion is complete, the AD7687 enters in acquisition phase and in reduced power mode. When CNV goes low, the MSB is output on SDO. The remaining data bits are then clocked by subsequent SCK falling edges. The data is valid on both SCK edges. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate. After the 16th SCK falling edge or when CNV goes high, whichever is the earliest, SDO returns to high impedance.

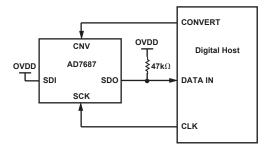


Figure 5. \overline{CS} mode 3 wires without busy indicator Connection Diagram (SDI high).

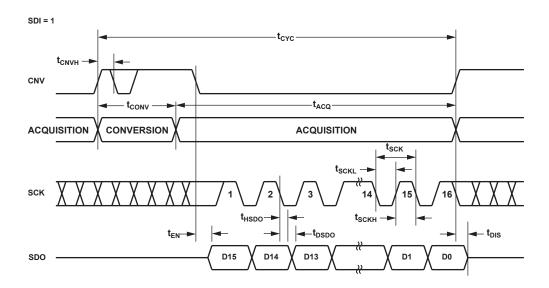


Figure 6. \overline{CS} mode 3 wires without busy indicator Serial Interface Timing (SDI high).

AD7687

CS MODE 3 wires with Busy indicator

This mode is usually used when a single AD7687 is connected to an SPI compatible digital host having an interrupt input.

The connection diagram is shown in figure 7 and the corresponding timing is given in figure 8.

With SDI tied to OVDD, a rising edge on CNV initiates a conversion, selects the $\overline{\text{CS}}$ mode and forces SDO in high impedance. SDO is maintained in high impedance until the completion of the conversion whatever the state of CNV is. Prior to the minimum conversion time, CNV could be used to select other SPI devices such as analog multiplexers but CNV must be returned low before the minimum conversion time and held low until the maximum conversion time to guarantee the generation of the busy signal indicator. When the conversion is complete, SDO goes from high impedance to low. With a pull-up on SDO line, this transition can be used as an interrupt signal to trigger the data reading controlled by the digital

host. The AD7687 also enters in acquisition phase and in reduced power mode. The data bits are then clocked out, MSB first, by subsequent SCK falling edges. The data is valid on both SCK edges. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate. After the 17th optional SCK falling edge or when CNV goes high whichever is the earliest, SDO returns to high impedance.

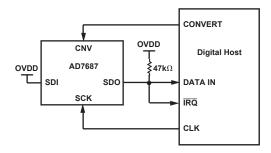


Figure 7. \overline{CS} mode 3 wires with busy indicator Connection Diagram (SDI high).

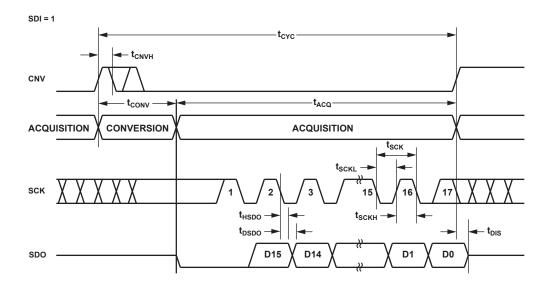


Figure 8. \overline{CS} mode 3 wires with busy indicator Serial Interface Timing (SDI high).

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CS MODE 4 wires without Busy indicator

This mode is usually used when multiple AD7687's are connected to an SPI compatible digital host.

A connection diagram example using two AD7687's is shown in figure 9 and the corresponding timing is given in figure 10.

With SDI high, a rising edge on CNV initiates a conversion, selects the \overline{CS} mode and forces SDO in high impedance. In this mode, CNV is held high during the conversion phase and the subsequent data reading. SDI must be high before the minimum conversion time and held high until the maximum conversion time to avoid the generation of the busy signal indicator. When the conversion is complete, the AD7687 enters in acquisition phase and in reduced power mode. Each ADC result can be read by bringing low its SDI input which outputs the MSB on

SDO. The remaining data bits are then clocked by subsequent SCK falling edges. The data is valid on both SCK edges. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate and more AD7687s on a single SPI port. After the 16th SCK falling edge or when SDI goes high whichever is the earliest, SDO returns to high impedance and another AD7687 can be read.

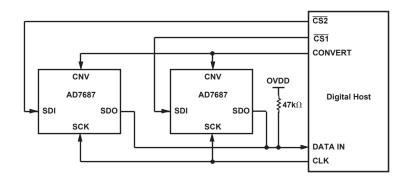


Figure 9. \overline{CS} mode 4 wires without busy indicator Connection Diagram.

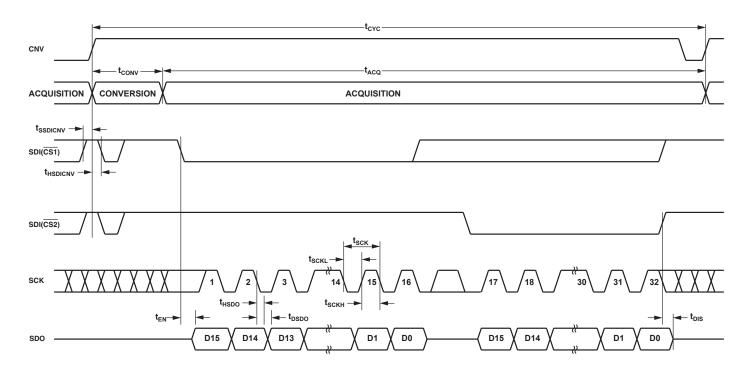


Figure 10. \overline{CS} mode 4 wires without busy indicator Serial Interface Timing.

AD7687

CS MODE 4 wires with Busy indicator

This mode is usually used when a single AD7687 is connected to an SPI compatible digital host having an interrupt input and it is desired to keep CNV, used to sample the analog input, independent of the signal used to select the data reading. This requirement is particularly important in applications where low jitter on CNV is desired.

The connection diagram is shown in figure 11 and the corresponding timing is given in figure 12. With SDI high, a rising edge on CNV initiates a conversion, selects the $\overline{\text{CS}}$ mode and forces SDO in high impedance. In this mode, CNV is held high during the conversion phase and the subsequent data reading. Prior to the minimum conversion time, SDI could be used to select other SPI devices such as analog multiplexers but SDI must be returned low before the minimum conversion time and held low until the maximum conversion time to guarantee the generation of the busy signal indicator.

When the conversion is complete, SDO goes from high impedance to low. With a pull-up on SDO line, this transition can be used as an interrupt signal to trigger the data reading controlled by the digital host. The AD7687 also enters in acquisition phase and in reduced power mode. The data bits are then clocked out, MSB first, by subsequent SCK falling edges. The data is valid on both SCK edges. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate. After the optional 17th SCK falling edge or SDI goes high whichever is the earliest, the SDO returns to high impedance.

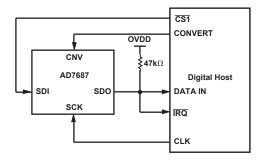


Figure 11. \overline{CS} mode 4 wires with busy indicator Connection Diagram .

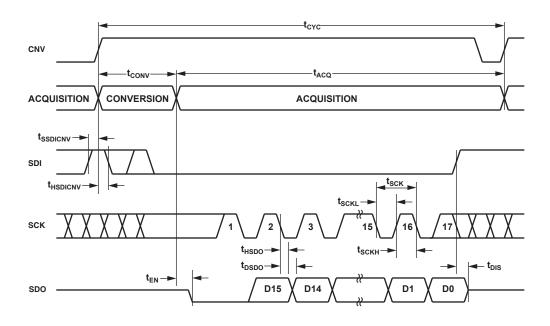


Figure 12. \overline{CS} mode 4 wires with busy indicator Serial Interface Timing.

Chain MODE without Busy indicator

This mode can be used to "daisy-chain" multiple AD7687's on a single 3 wire serial interface. This feature is useful for reducing component count and wiring connections when desired as, for instance, in isolated multiconverter application or for systems with a limited capacity for interfacing to a large number of converters. A connection diagram example using two AD7687's is shown in figure 13 and the corresponding timing is given in figure 14.

With SDI tied to ground, SDO is low when CNV is low. With SCK low, a rising edge on CNV initiates a conversion, selects the Chain mode and disables the busy indicator. In this mode, CNV is held high during the conversion phase and the subsequent data reading. When the conversion is complete, the MSB is output on SDO, the

AD7687 enters in acquisition phase and in reduced power mode. The remaining data bits stored in the internal output data shift register are then clocked by subsequent SCK falling edges. This internal output data shift register is also filled in on each SCK falling edge by the SDI data. By connecting SDO output of an "upstream" device to the SDI input of a "downstream" device, after the 16th SCK falling edge, the MSB of the "upstream" device is output on SDO and, consequently, the result of all devices in the chain is output serially on the SDO output of the last "downstream" device. The data is valid on both SCK edges. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate and more AD7687s in the chain. For instance, with a 5ns digital host set-up time and 5V interface, up to five AD7687's running at the maximum conversion rate of 250 kSPS can be "daisy-chain" to a single 3 wire port.

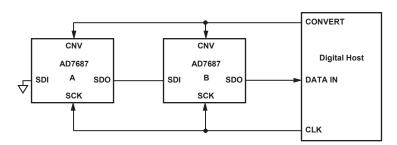


Figure 13. Chain mode without busy indicator Connection Diagram.

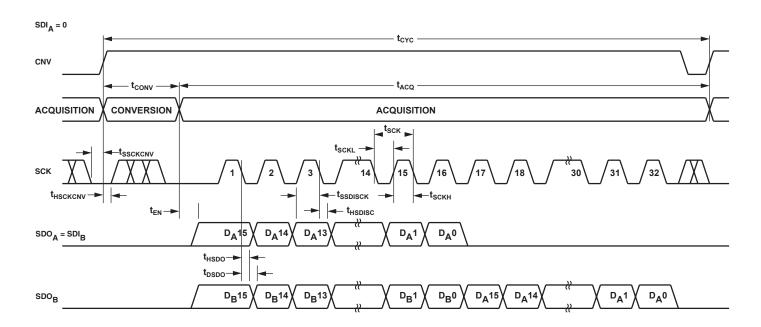


Figure 14. Chain mode without busy indicator Serial InterfaceTiming.

AD7687

Chain MODE with Busy indicator

This mode can also be used to "daisy-chain" multiple AD7687's on a single 3 wire serial interface while providing a busy indicator.

A connection diagram example using three AD7687's is shown in figure 15 and the corresponding timing is given in figure 16.

With SDI and CNV tied together, SDO is low when CNV is low. With SCK high, a rising edge on CNV/SDI initiates a conversion, selects the Chain mode and enables the busy indicator feature. In this mode, CNV is held high during the conversion phase and the subsequent data reading. When the conversion is complete and SDI is high, SDO goes high, this transition on SDO can be used as an interrupt signal to trigger the data reading controlled by the digital host. The AD7687 also enters in acquisition

phase and in reduced power mode. The data bits stored in the internal output data shift register are then clocked out, MSB first, by subsequent SCK falling edges. This internal output data shift register is also filled in by the SDI data on each SCK falling edge except the first one. By connecting SDO output of an "upstream" device to the SDI input of a "downstream" device, after the 17th SCK falling edge, the MSB of the "upstream" device is output on SDO and, consequently, the result of all devices in the chain is output serially on the SDO output of the last "downstream" device. Similarly, the busy indicator propagates through the chain such that SDO goes high only when all upstream devices conversions are complete. Although the rising edge can be used to capture the data, a digital host with acceptable hold time using the SCK falling edge will allow a faster reading rate and more AD7687s in the chain. For instance, with a 5ns digital host set-up time and 5V interface, up to five AD7687's running at the maximum conversion rate of 250 kSPS can be "daisy-chain" to a single 3 wire port.

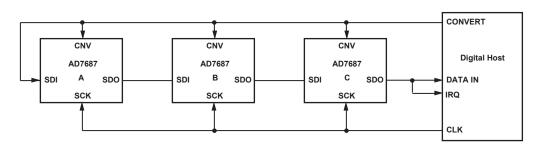


Figure 15. Chain mode with busy indicator Connection Diagram.

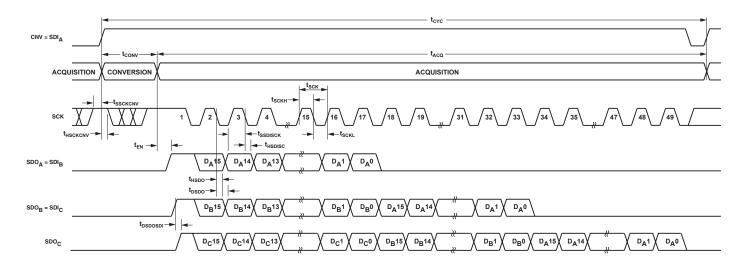
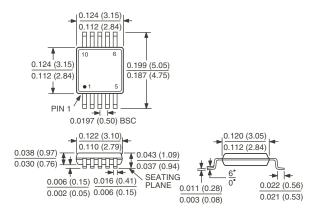


Figure 16. Chain mode with busy indicator Serial Interface Timing.

OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

10-Lead μSOIC (RM-10)



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